

# ABSTRACT

Particles in a glass substrate are measured by  
executing following steps: sequentially conveying a  
5 plurality of glass substrates; scanning with a camera a unit  
area of a glass substrate in a direction of a travel path of  
the glass substrate and storing particle information  
thereof; shifting the camera to a position corresponding to  
a next unit area for a succeeding glass substrate; storing  
10 information on the particles in the unit area of the  
succeeding glass substrate obtained by scanning the glass  
substrate; estimating whether a sum of the respective  
scanned unit areas is within an allowed limit of an area of  
a glass substrate; and returning to the third step if an  
15 answer from the fifth step is "No" or storing information on  
the particles in the entire glass substrate if the answer is  
"Yes".